



# HYPERION II

- FT-IR | FPA | IR Laser Imaging Microscope

Bruker's IR microscope HYPERION has always been synonymous with sensitivity and versatility. For more than 20 years, it pioneered FT-IR imaging and left its mark in countless high-profile publications.

With HYPERION II, we remain true to our reputation as an innovation leader. For the first time ever, FT-IR and QCL technology are combined in a single instrument.

This innovative approach gives scientists and researchers a new, versatile tool to further develop established applications and discover exciting possibilities.





The HYPERION II covers all the fundamental techniques beginning with the most widespread use: FT-IR microscopy. It finds use in general research, forensics, failure analysis, life-science and electronics:

- Thermoelectrically and liquid nitrogen cooled MCTs
- Visual and IR contrast enhancement tools
- Wide range of objective lenses and accessories available
- Dedicated ATR objective with integrated pressure sensor

FT-IR Microscopy

FT-IR Imaging

Take your chemical FT-IR imaging to the next level with focal-plane array (FPA) detector technology. It offers superb spatial resolution and peak sensitivity in all measurement modes:

- True IR imaging by focal plane array technology
- High spatial resolution and full ATR compatibility
- Low-magnification objective lenses for fast chemical overviews
- High-magnification objective lenses to find smallest details



Bruker's infrared laser imaging modules (ILIM) opens the door to enhance existing and discover brand new applications. The HYPERION II combines QCL technology and FT-IR into one system:

- Create high-contrast IR images at unprecedented speed
- Seamless combination of FT-IR and QCL measurements
- IR Live Imaging allows observation of samples in real-time
- QCL Imaging in all measurement modes: transmission, reflection and ATR

IR Laser Imaging

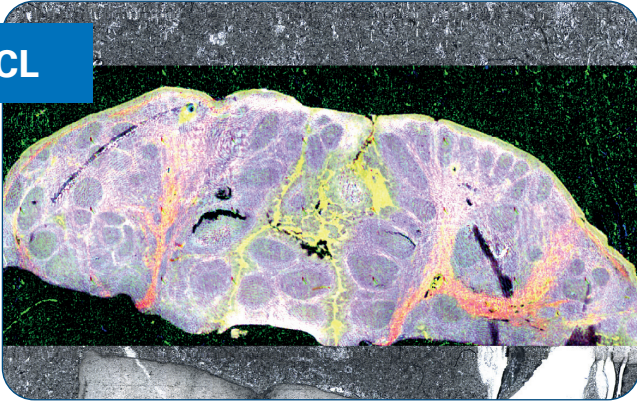
The HYPERION II is compatible with INVENIO and the VERTEX series FT-IR spectrometers.



# • Applications of Infrared Microscopy

## Life Science

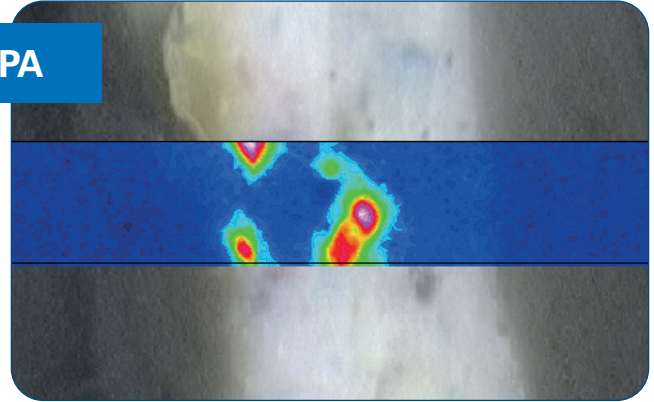
QCL



The potential of QCL technology for life science is huge. This microtome section of tonsil tissue was analyzed by superimposing the IR laser image on the visual data.

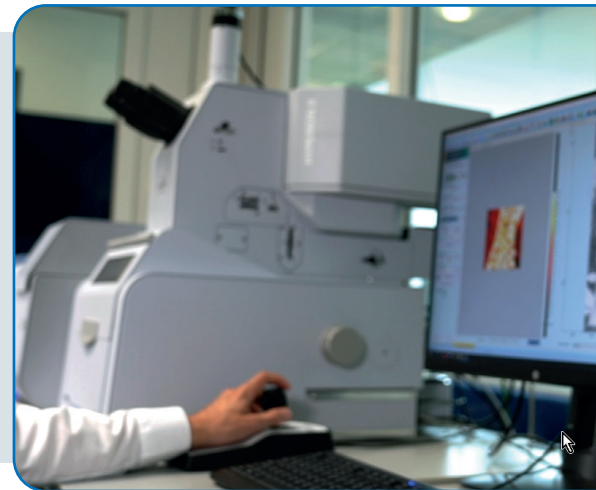
## Pharmaceuticals

FPA



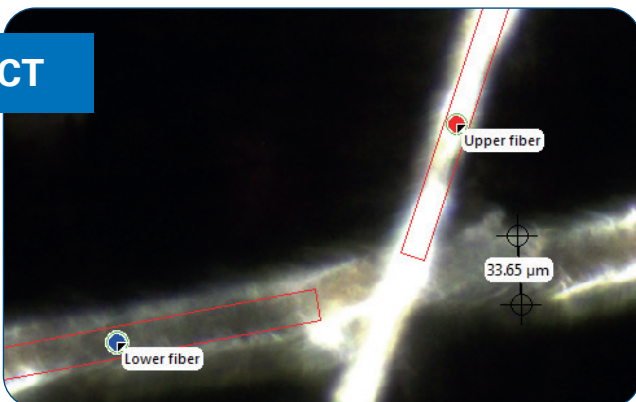
Determining the ingredients of a mixture has never been so easy. In this case, a pharmaceutical pellet was analyzed for impurities. The impurity (red) stands out clearly from the API matrix (blue).

- Use FT-IR and QCL in any measurement mode: transmission, reflectance, and ATR.
- Amazing live IR imaging view: explore your sample through the eyes of the spectrometer in real-time.
- Access spectral range extensions (VIS/NIR) and utilize emission or fluorescence spectroscopy.



## Forensics

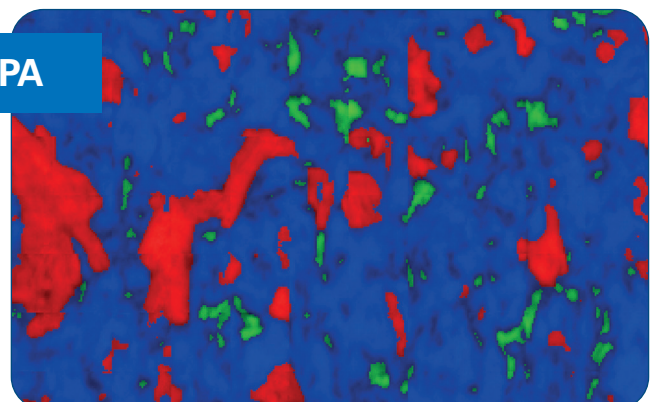
MCT



IR microscopy is an outstanding tool for forensic science. In this case, fibers were examined to obtain clear evidence of their origin. Knife-edge apertures ensured optimal spectral quality.

## Polymers

FPA

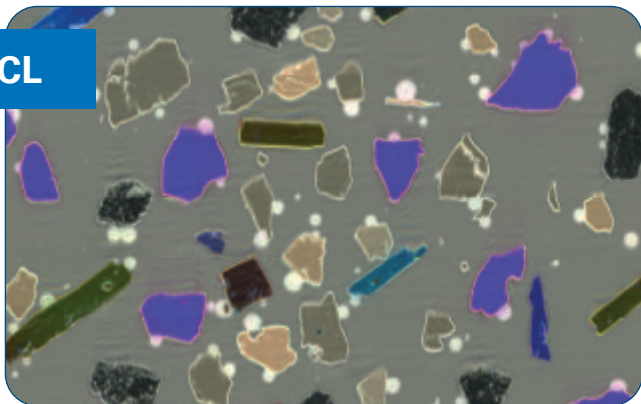


Composition, thickness and homogeneity of this polymeric material is easily assessed by  $\mu$ -FT-IR. False-color image shows: POM (blue), PTFE (green) and Aramide (red).



## Geology

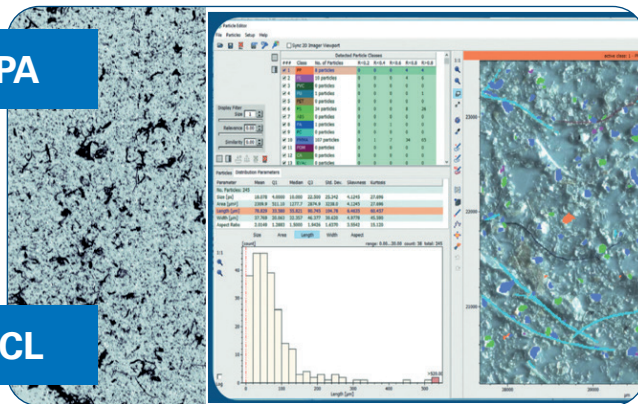
QCL



Infrared laser imaging readily evaluates minerals and geochemical properties. The example above shows the differentiation of various oxide minerals based on their reflectance properties.

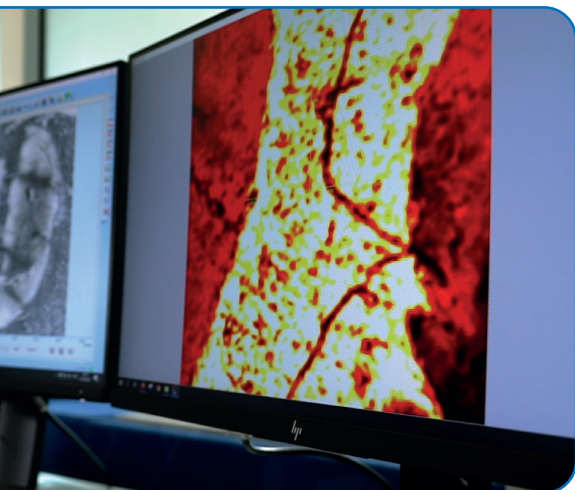
## Microplastics

FPA



QCL

FT-IR imaging is the gold standard in microplastics analysis but IR laser imaging is catching up fast. Left: IR laser image; Right: automated microplastics analysis.



- Highest flexibility and spectral performance are the key features of HYPERION II.
- Make your instrument more sustainable by choosing a high-sensitivity thermoelectrically cooled MCT.
- Easy customization for applications through a wide range of accessories and objective lenses.

## Multi-Layer

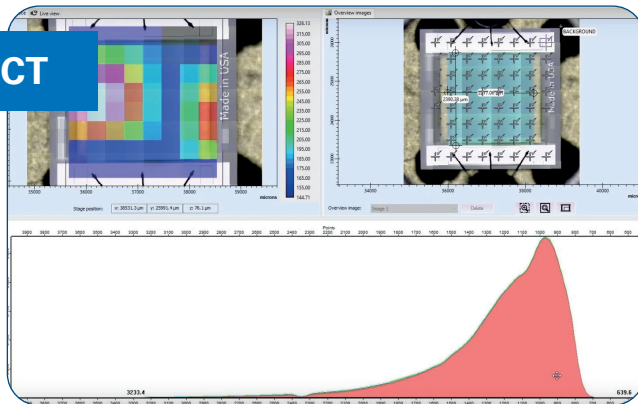
FPA



IR imaging makes it easy to analyze laminates and multilayer structures. This multilayer paint chip was examined using high-resolution ATR imaging to determine the cause of a car accident.

## Sensor Technology

MCT



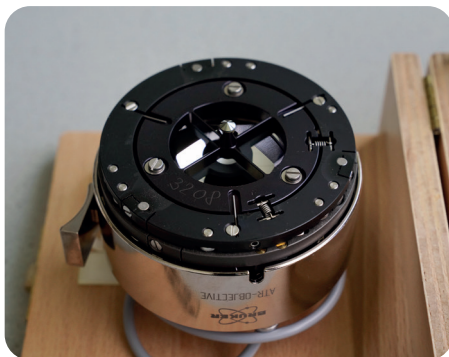
The quality and emission behavior of IR emitters (e.g. voxels or LEDs) can be checked by  $\mu$ -FT-IR. The above picture shows an inhomogeneous radiation distribution of an LED.

## • Ready for Any Sample - Objective Lenses



### 3.5x IR Objective

Provides broad spectral range and low chromatic aberration and distortion. Lenses are made from IR transparent material and provide high IR throughput to achieve excellent signal to noise.



### 20x ATR Objective

Offers clear sample viewing and high infrared throughput. Internal pressure sensor reproducibly ensures optimal contact between the sample and the crystal during data acquisition.



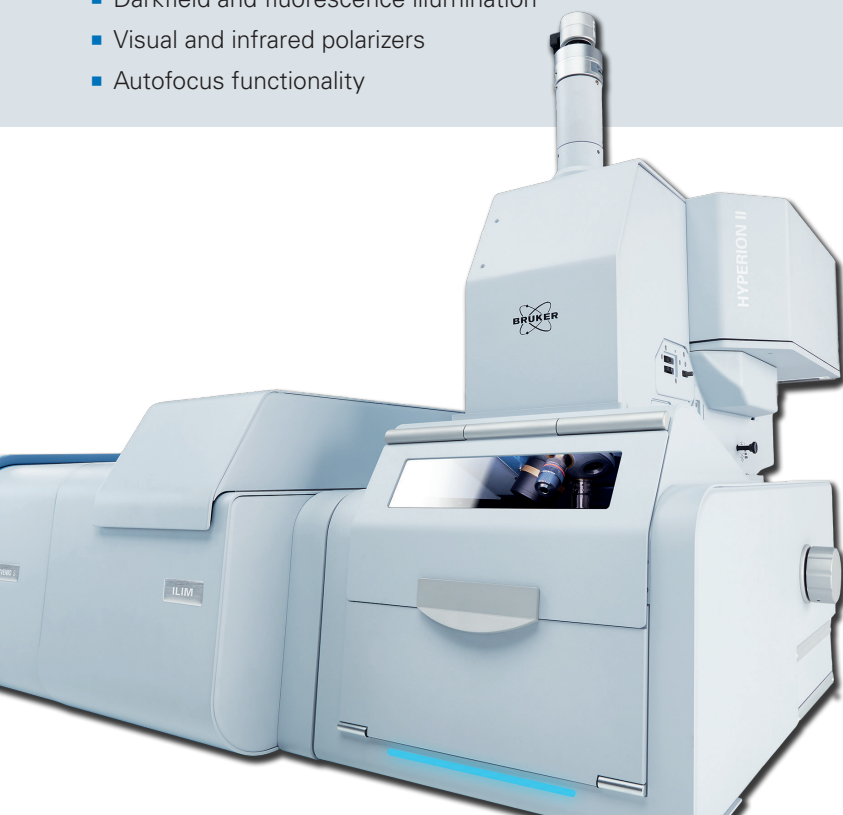
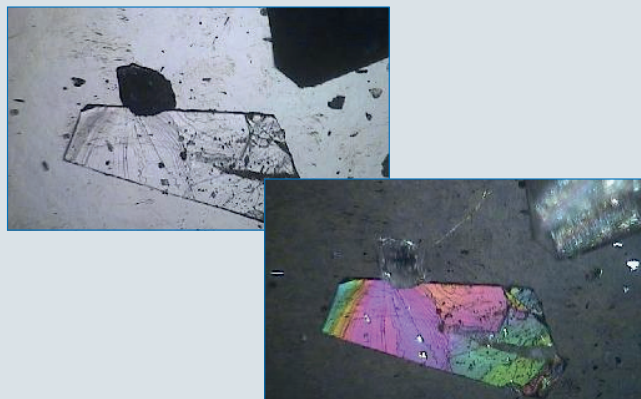
### 15x Grazing Angle Objective

Designed for the microanalysis of thin coatings on metallic substrates with extremely high sensitivity. Retains the polarization characteristics of the applied infrared beam.

## Visualization Tools

The first step of any microscopic analysis is visual inspection and location of regions of interest. For this, the HYPERION II packs multiple tools to enhance the visual quality of your analysis. It offers:

- 5 MP CMOS camera and binocular (optional)
- Contrast irises ("Köhler" apertures)
- Darkfield and fluorescence illumination
- Visual and infrared polarizers
- Autofocus functionality



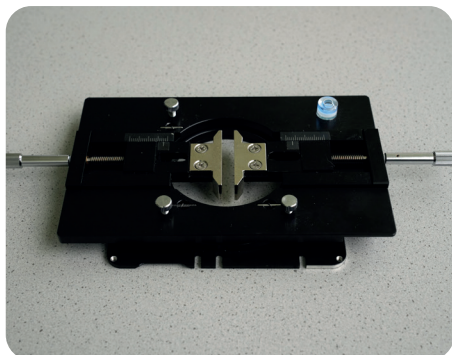
### Sample Compartment

The sealed sample compartment establishes stable experimental conditions for sensitive and demanding samples. For infrared laser imaging (QCL), the compartment doubles as a laser safety enclosure to protect the user from hazardous radiation.

- Stable atmospheric conditions
- Allows continuous flow of inert gas or dry air
- Required for ILIM, optional for FT-IR
- HYPERION II is a laser safety class 1 product

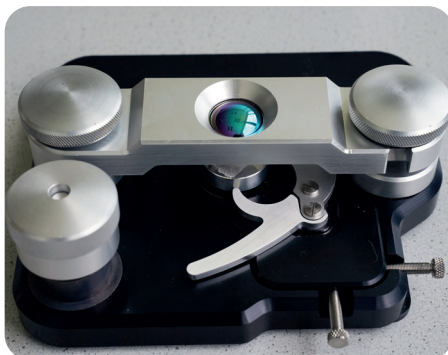


## • Full Flexibility - Sampling Accessories



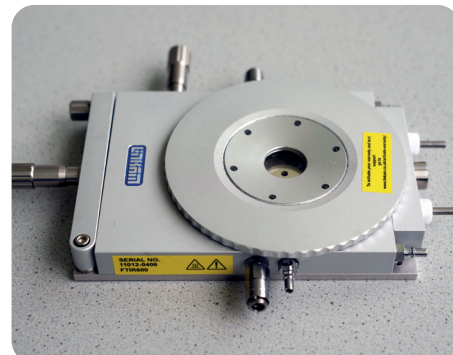
### Universal Sample Holder

Holds round and unevenly shaped samples such as tablets, minerals, etc. in the desired position and allows sample tilt for correcting oblique sample orientations.



### Macro ATR Imaging

Enables microscopic IR analysis of sticky, brittle or particularly soft specimen by clamping them to a large Germanium ATR crystal with a tip size of about  $\text{\O} 1000 \mu\text{m}$ .



### Temperature Controlled

Performs thermal experiments. This precise heating and cooling stage covers a temperature range from  $-196^{\circ}\text{C}$  up to  $600^{\circ}\text{C}$  to study the behavior of samples exhibiting polymorphism or decomposition.

## Spectral Range Extensions and Detectors

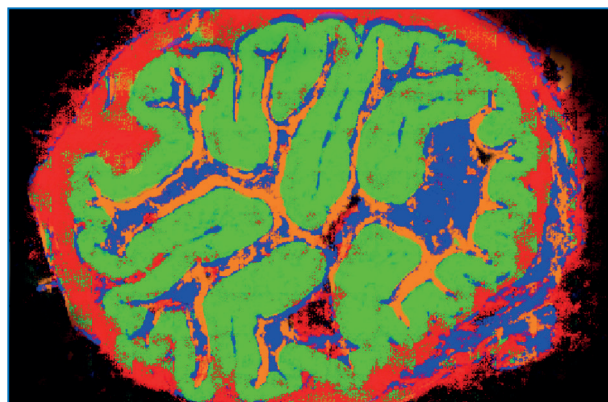
One of the many strengths of the HYPERION II is the adaptability to the analytical requirements. Equipped with a wide variety of detectors, it can cover a very broad spectral range, from the visible (VIS, up to  $20.000 \text{ cm}^{-1}$ ) to the far-infrared (FIR, down to  $150 \text{ cm}^{-1}$ ).

In addition to the manual, easily interchangeable knife edge and iris apertures, aperture wheels and automated, software-controlled knife-edge apertures are also available. The HYPERION II can be equipped with up to two detectors in parallel, where the switching between positions is controlled by the software.

### OPUS IR Software

Our all-in-one software OPUS provides the fundament for optimal measurements and evaluations. The user-guided software interface makes microscopic investigations an easy task for users of any skill level.

- Spectral contrast calculation during IR image recording
- Autonomous IR image analysis by Bruker's adaptive K-means clustering
- Create RGB images, 3D cluster analysis, PCA analysis, machine learning and much more.
- Correlate your visual and IR data in 2D and 3D
- Select spectra by similarity from 3D data files
- Use smart filter options to interpret data
- Full feature-compatibility with QCL
- Python interface for increased evaluation flexibility, allows user to develop and use their own methods



Localize different components and points of interest of your sample completely automated. The above image shows the Result of k-means cluster algorithm of an FT-IR Image with 2 million spectra. Everything was determined automatically within around 10 seconds.

# • Combining FT-IR and QCL Technology

It is often implied that both techniques are interchangeable - a popular misconception. Since FT-IR and infrared laser imaging both have distinct and unique advantages, a combination of both into one instrument is the optimal choice.

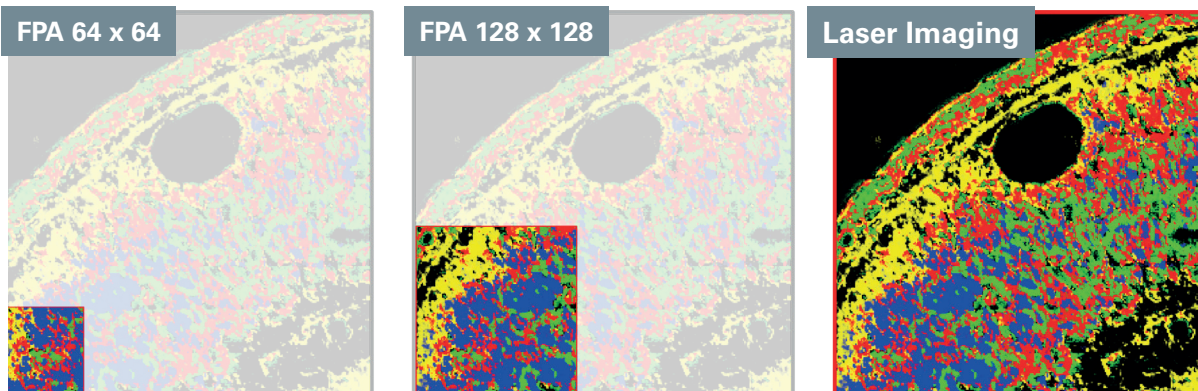
## Fundamental Differences:

Technical Specification	FT-IR	Infrared Laser Imaging
<b>Source</b>	<ul style="list-style-type: none"> <li>▪ Globar (black body radiation)</li> </ul>	<ul style="list-style-type: none"> <li>▪ Monochromatic (Tunable MIR Laser)</li> </ul>
<b>Data Collection</b>	<ul style="list-style-type: none"> <li>▪ All wavelength at once</li> <li>▪ Collection of full spectra</li> </ul>	<ul style="list-style-type: none"> <li>▪ Sequential wavelength acquisition</li> <li>▪ Imaging at fixed wavelengths</li> <li>▪ Imaging at defined spectral ranges</li> </ul>
<b>Spectral Range</b>	<ul style="list-style-type: none"> <li>▪ Full MIR spectral range</li> </ul>	<ul style="list-style-type: none"> <li>▪ MIR fingerprint</li> </ul>

## Focal-Plane Array vs. Infrared Laser (QCL) Imaging:

Technical Specification	FT-IR Imaging by FPA		IR Laser Imaging
<b>Simultaneous Spectra</b>	4096 (64x64 FPA)	16.384 (128x128 FPA)	Up to 90.000 (300x300 pixel)
<b>Spectral Range</b>	MIR	MIR	950 - 1800 $\text{cm}^{-1}$
<b>Pixel Size</b>	0.5 - 11 $\mu\text{m}/\text{pixel}$	0.5 - 11 $\mu\text{m}/\text{pixel}$	0.2 - 4.9 $\mu\text{m}/\text{pixel}$
<b>Field of View @ 3.5x</b>	730x730 $\mu\text{m}$	1460x1460 $\mu\text{m}$	1460x1460 $\mu\text{m}$
<b>Full Spectrum Speed at 16 <math>\text{cm}^{-1}</math></b>	400 spectra/second	800 spectra/second	30.000 spectra/second
<b>Full Spectrum Imaging at 16 <math>\text{cm}^{-1}</math></b>	32 minutes/ $\text{cm}^2$	16 minutes/ $\text{cm}^2$	3 minutes/ $\text{cm}^2$
<b>Single Wavelength Imaging</b>	-	-	6.4 $\text{mm}^2/\text{second}$ 15 seconds/ $\text{cm}^2$

## Sample Area Imaging Comparison

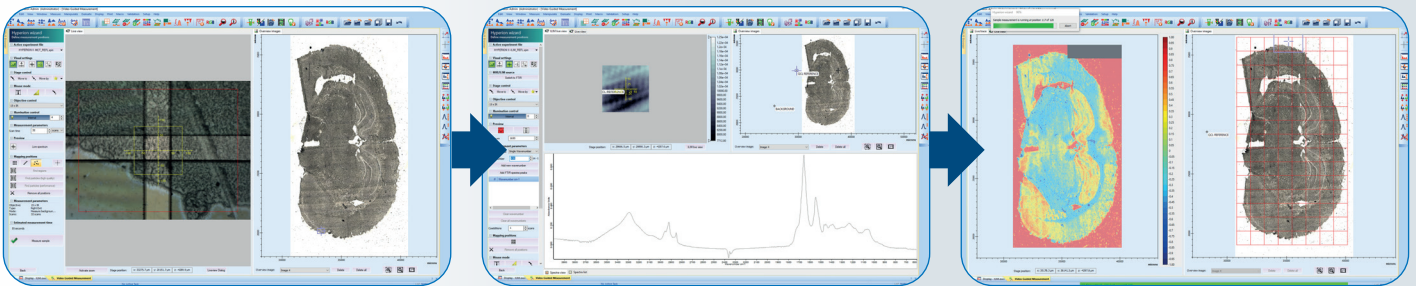


These images clearly show the speed advantage of infrared laser imaging compared to FT-IR FPA imaging. In a full spectral scan (16  $\text{cm}^{-1}$ ) and one minute these areas can be imaged: 64x FPA = 2  $\text{mm}^2$ , 128x FPA = 4  $\text{mm}^2$ , IR Laser= 20  $\text{mm}^2$ . Defined tasks can often be solved by the collection of just a few spectral bands instead of whole spectra, thus reducing the time to about 6 seconds for the same area or increasing the area to around 350  $\text{mm}^2$  per wavenumber.



# FT-IR and QCL. In one easy workflow.

In conclusion, only a practical combination of both can achieve the best results. Fortunately, the HYPERION II can be considered both: an exceptional FT-IR imaging microscope and an ambitious QCL microscope.



**ROIs for an FT-IR measurement  
are defined on the visual image**

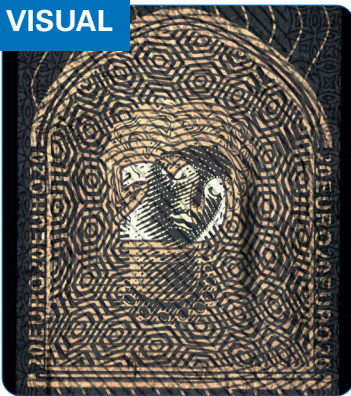
**Peaks are selected for  
infrared laser imaging**

**A chemical Image is  
recorded in seconds!**

**Note:** This process can also be turned around: IR Laser Imaging is used to prescreen a sample quickly and only collect FT-IR spectra at selected regions of interest.

## Spatial coherence artifacts? Never with HYPERION II.

**VISUAL**



**QCL**



This image shows a comparison between visual and IR Laser Image. Thanks to the patented\* coherence reduction the IR Laser Image is virtually artifact free and exhibits the same quality as the visual one. HYPERION II delivers unprecedented image quality for IR Laser Imaging.

Whether in transmission, reflectance or attenuated total reflectance in combination with MCT, FPA or QCL. With the HYPERION II you can always rely on crisp and clear images and pristine data. Our patented\*, hardware-based coherence reduction enables users to acquire razor-sharp infrared images without Interference artefacts – for the first time in QCL based imaging.

# HYPERION II at a glance.



## About HYPERION II

The Bruker HYPERION II is the first IR microscope that combines cutting edge infrared laser imaging, that enables unrivaled imaging speeds, with classical and versatile FT-IR microscopy in just one single device.

Whether you are looking for basic identification routines or high-speed imaging solutions, you'll immediately notice, that there is no way around the HYPERION II.

## About Bruker

We want to make your application a complete success. Our Team of scientists and engineers offer tons of practical experience to support you.

We want to earn your trust when it comes to questions regarding the selection of the best equipment for difficult analytical problems.

Bruker's FT-IR devices ensure consistent performance for years to come. During a maintenance situation, you can count on our global network of service engineers who are ready to deal with any issues quickly and skillfully.

## Technical Features:

The HYPERION II is our versatile FT-IR microscope for research and development with flexible accessories and the possibility to combine infrared laser imaging (QCL) and FT-IR in one instrument:

- QCL implementation for infrared laser imaging (laser class 1)
- Focal-plane array for FT-IR Imaging (64x64 or 128x128)
- TE-MCT and broad-, mid, narrow-band LN2-MCTs
- Available objective lenses: 3.5x/15x/36x/74x IR, 20x ATR, 15x GIR, 4x/40x VIS
- Manual/automated knife-edge aperture or aperture wheel
- NIR – FIR Spectral range extension available
- Wide selection of accessories and sample stages: macro-ATR imaging accessory, cooling/heating stage, specialized sample holders, sample compartment, etc.
- Visual enhancement tools and sample stages: darkfield/fluorescence illumination, VIS/IR polarizers, etc.
- The HYPERION II is compatible with INVENIO and the VERTEX series FT-IR spectrometers.

Covered by one or more of the following patents: DE102004025448; JP-6779982-B2; US-2018157019-AA. Additional patents pending.

**Bruker Optics is ISO 9001  
and ISO 13485 certified.**

Laser class 1 product.

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